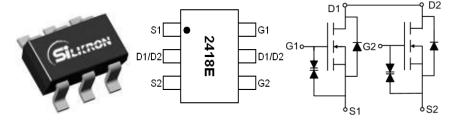


Main Product Characteristics:

V _{DSS}	20V
R _{DS} (on)	18mohm(typ.)
I _D	6A



SOT23-6

Marking and pin
Assignment

Schematic diagram

Features and Benefits:

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



Description:

It utilizes the latest trench processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications

Absolute max Rating:

Symbol	Parameter	Max.	Units	
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V①	6		
I _{DM}	Pulsed Drain Current②	30	A	
P _D @TC = 25°C	Power Dissipation③	1.3	W	
V _{DS}	Drain-Source Voltage	20	V	
V_{GS}	Gate-to-Source Voltage	± 12	V	
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C	

Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-ambient (t \leq 10s) $\stackrel{.}{ ext{4}}$		95	°C/W





Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	20	_	_	V	V _{GS} = 0V, ID = 250μA
	Otatia Danie ta Ocumenta	_	18	21	mΩ	V_{GS} =4.5 V , I_{D} = 6 A
D		_	19	22		$V_{GS}=4V, I_{D}=5.5A$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	_	21	26	11122	$V_{GS}=3.1V, I_{D}=5A$
		ı	25	30		$V_{GS}=2.5V, I_{D}=4A$
$V_{GS(th)}$	Gate threshold voltage	0.5	_	1	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
I _{DSS}	Drain-to-Source leakage current	_	_	1	μΑ	$V_{DS} = 20V, V_{GS} = 0V$
	Cata to Source forward lookage	_	_	10	μΑ	V _{GS} =10V
I_{GSS}	Gate-to-Source forward leakage	-10	_	_		V _{GS} = -10V
g FS	Forward Transconductance	_	7	_	S	V _{DS} =5V,I _D =6A
Q_g	Total gate charge	_	8	_		V _{DS} =10V,
Q_{gs}	Gate-to-Source charge	_	1.5	_	nC	I _D =6A,
Q_{gd}	Gate-to-Drain("Miller") charge		2	_		V _{GS} =4.5V
t _{d(on)}	Turn-on delay time	_	20	_		
t _r	Rise time	_	50	_	20	V_{DD} =10 V , I_{D} =1 A
$t_{\text{d(off)}}$	Turn-Off delay time		64	_	ns	V_{GS} =4.5 V , R_{GEN} =10 Ω
t _f	Fall time		40	_		
C _{iss}	Input capacitance		650	_		V _{GS} = 0V
Coss	Output capacitance		170	_	pF	V _{DS} = 10V
C _{rss}	Reverse transfer capacitance	_	150	_		f = 1.0MHz

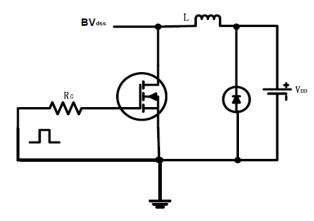
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current			6	А	MOSFET symb
Is	(Body Diode)	_				showing the
	Pulsed Source Current		_	30	А	integral reverse
ISM	(Body Diode)	_				p-n junction diode.
V _{SD}	Diode Forward Voltage	_	0.76	1.1	V	I _S =1A, V _{GS} =0V

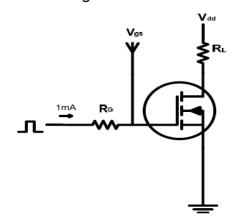


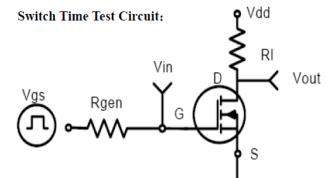
Test circuits and Waveforms

EAS test circuits:

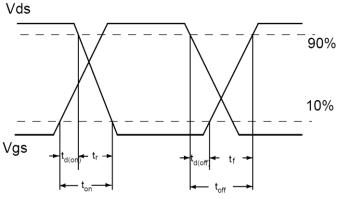


Gate charge test circuit:





Switch Waveforms:





Typical electrical and thermal characteristics

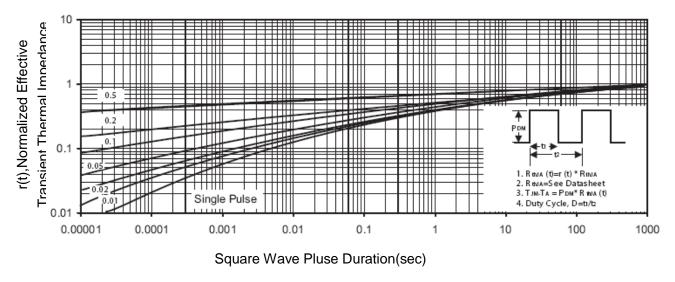


Figure 1 Normalized Maximum Transient Thermal Impedance

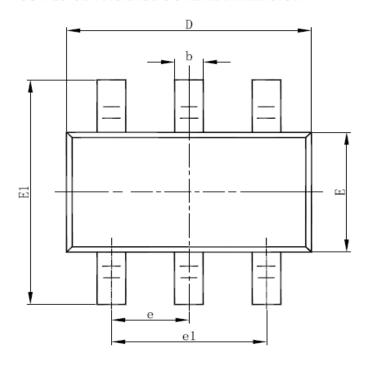
Notes:

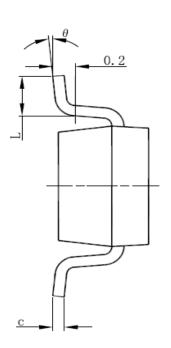
- ①The maximum current rating is limited by bond-wires.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4The value of $R_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C
- ⑤These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=150$ °C.
- 6 The maximum current rating is limited by bond-wires.

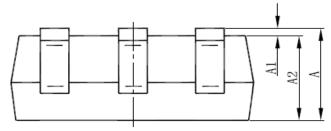


Mechanical Data:

SOT-23-6L PACKAGE OUTLINE DIMENSION







Cymphal	Dimension I	n Millimeters	Dimension In Inches		
Symbol	Min	Max	Min	Max	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
Е	1.500	1.700	0.059	0.067	
E1	2.650	2.950	0.104	0.116	
е	0.95(BSC)		0.037	(BSC)	
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	00	8 ⁰	00	8 ⁰	





Ordering and Marking Information

Device Marking: 2418E

Package (Available)
SOT23-6
Operating Temperature Range
C: -55 to 150 °C

Devices per Unit

Package	Units/	Tapes/	Units/	Inner Boxes/	Units/
Туре	Tape	Inner Box	Inner Box	Carton Box	Carton Box
SOT23-6	3000	10	30000	4	120000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			



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